

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/624,556	YOON ET AL.
	Examiner NABIL Z. HINDI	Art Unit 2627

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
369	44-34	1/22/07	MM
	47-27		
	124-15	1/20/07	MM